Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/815,370	YEH ET AL.	
Examiner	Art Unit	
TRONG PHAN	2827	

	SEAR	CHED	
Class	Subclass	Date	Examiner
365	185.11	12/21/2005	TP
	185.18		
	185.28		-
	185.29		
	185.33		
			-

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
	1					

	SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR		
EAST		12/21/2005	ТР		
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